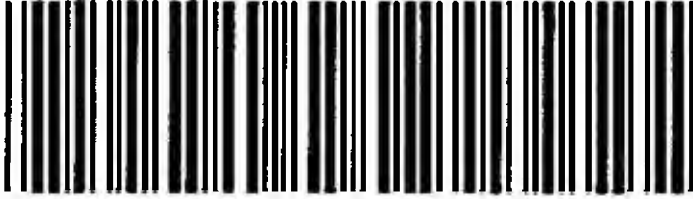


<div>Search Notes</div> <div></div>	Application No.	Applicant(s)	
	10/604,817	CHEN, YUEH-CHANG	
	Examiner	Art Unit	
	Peguy JeanPierre	2819	

SEARCHED			
Class	Subclass	Date	Examiner
341	143		
	110		
	111		
375	269		
	272	3/3/2004	PJP

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
341	143		
	110		
375	269	3/3/2004	PJP

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
EAST		
FSK in which pair of sample points are compared to determine sample correcting number; samples being compared are;		
symmetric to a central value; one of the pair is compared to the centrvalvalue to determine sample direction	3/3/2004	PJP